## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/532,155	VANDERPERREN ET AL.	
Examiner	Art Unit	
NAHEED EJAZ	2611	

SEARCHED					
Class	Subclass	Date	Examiner		
375	130,139, 147,150, 316,322	3/28/2008	NE		
375	324	3/28/2008	NE		
375	335,340	3/28/2008	NE		
375	343	3/28/2008	NE		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	326	3/28/2008	NE	
316,322,32	39,147,150, 24,335,340,	3/28/2008	NE	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST search attached	3/28/2008	NE		
Inventorship	3/28/2008	NE		
Consulted with SPE Chieh M. Fan	3/28/2008	NE		